

# Search Notes



Application/Control No.

10/720,502

Examiner

Tran N. Nguyen

Applicant(s)/Patent under Reexamination

HAMA ET AL.

Art Unit

2834

## SEARCHED

Class	Subclass	Date	Examiner
310	239 249 71	2/22/05 ↓	Tran ↓

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
310	all in base	2/26/05	Tran

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR